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4 Revision History

DATE	REVISION	NOTES
July 2023	*	Initial Release

5 Pin Configuration and Functions

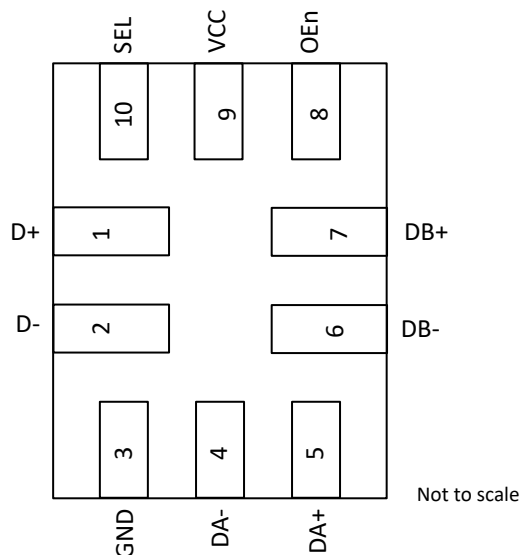


图 5-1. TMUXHS221LV NKG Package, 10-Pin UQFN (Top View)

表 5-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
D+	1	I/O	Data signals Common Port, positive
D-	2	I/O	Data signals Common Port, negative
DA+	5	I/O	Data signals Port A, positive
DA-	4	I/O	Data signals Port A, negative
DB+	7	I/O	Data signals Port B, positive
DB-	6	I/O	Data signals Port B, negative
SEL	10	IN	Switch control configuration signal as provided in 表 7-1 .
OEn	8	IN	
VCC	9	P	1.8 V power supply
GND	3	G	Ground

(1) IN = input, I/O = input or output, P = power, G = ground

6.8 Typical Characteristics – S-Parameters

图 6-1 和 图 6-2 显示典型 TMUXHS221LV 通道的差分插入损耗和回波损耗，分别。该出色的高速性能在 240 MHz 导致对 USB 2.0 或 eUSB2 HS 信号眼图的最小衰减。图 6-3 显示典型 TMUXHS221LV 通道的差分串扰。注意，提供的测量是在 TI 评估板上进行的，该板具有校准出的板级和设备寄生元件。

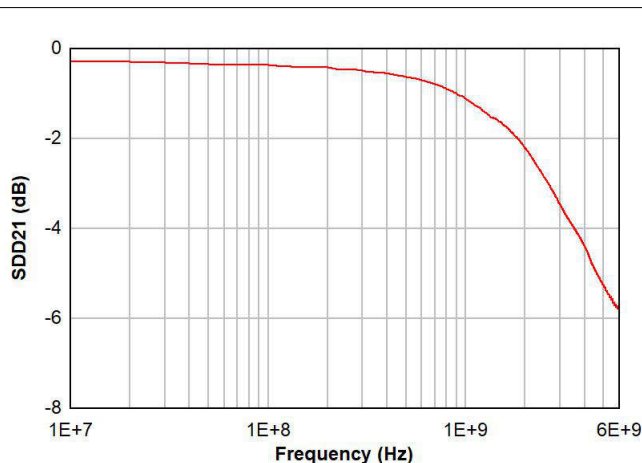


图 6-1. Typical Differential Insertion Loss vs Frequency

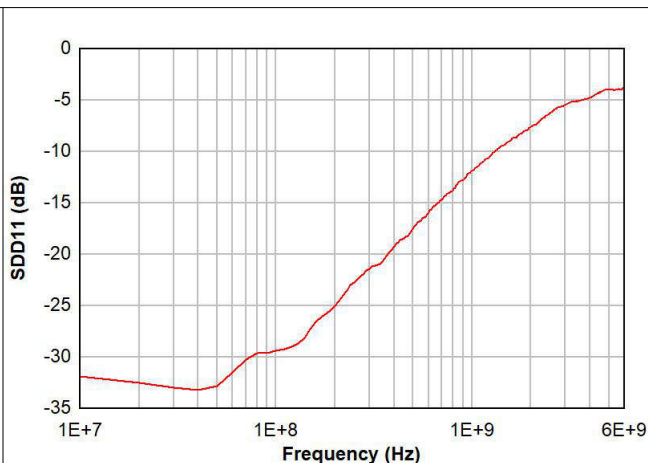


图 6-2. Typical Differential Return Loss vs Frequency

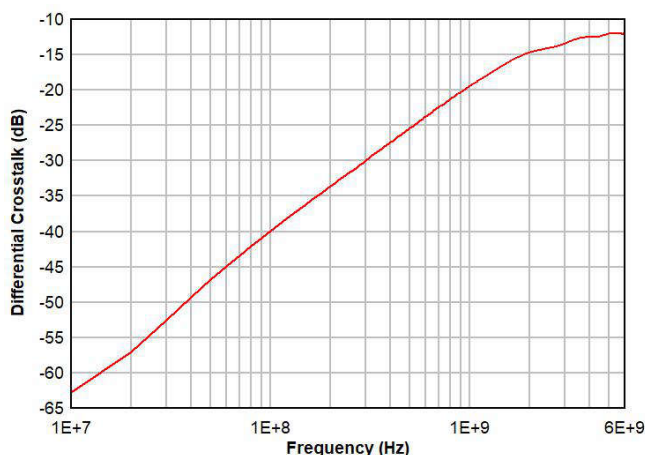


图 6-3. Typical Differential Crosstalk vs Frequency

6.9 Typical Characteristics – R_{ON}

图 6-4, 图 6-5, and 图 6-6 show switch ON resistance R_{ON} versus common mode voltage VCM, supply voltage VCC, and ambient temperature respectively. All curves are at nominal PVT conditions unless specified.

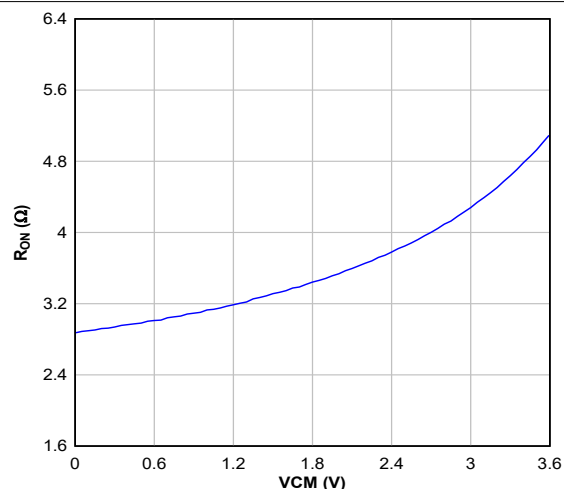


图 6-4. R_{ON} vs Common Mode Voltage VCM

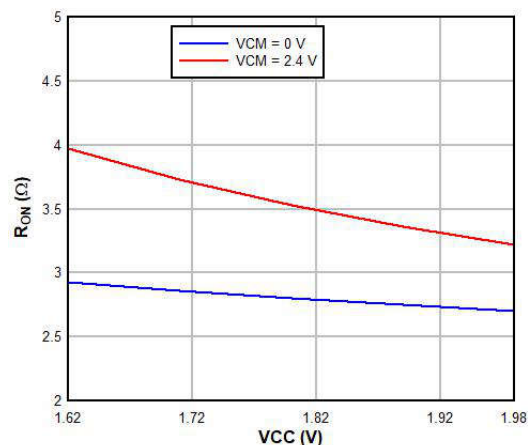


图 6-5. R_{ON} vs Supply Voltage VCC

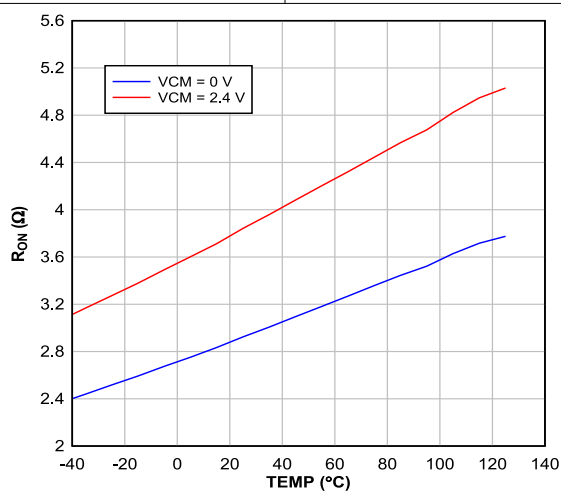


图 6-6. R_{ON} vs Ambient Temperature

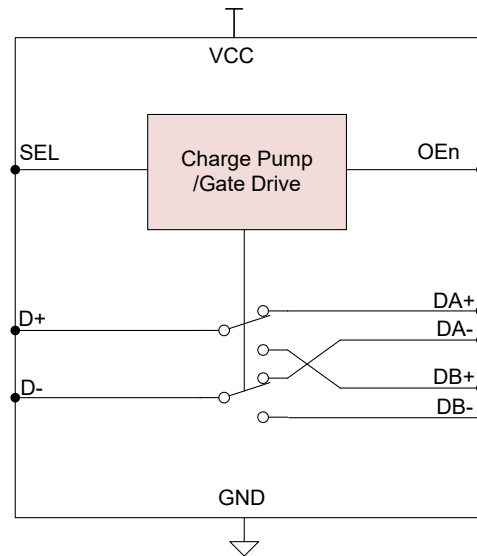
7 Detailed Description

7.1 Overview

The TMUXHS221LV is an analog passive mux with 2:1 or 1:2 multiplexer or demultiplexer that can work for any low-speed, high-speed, differential or single-ended signals. The signals must be within the allowable voltage range of -0.3 to 3.6 V. The device is optimized for eUSB2 and USB 2.0 LS, FS, and HS signaling.

The dynamic characteristics of the device allow high-speed switching with minimal attenuation to the signal eye diagram and little added jitter. While the device is recommended for the interfaces up to 3Gbps, actual data rates where the device can be used highly depends on the electrical channels. For low loss channels where adequate margin is maintained, the device can potentially be used for higher data rates.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Output Enable and Power Savings

The TMUXHS221LV has two power modes: active, or normal, operating mode and standby, or shutdown mode. During standby mode, the device consumes very little current to achieve ultra low power in systems where saving power is critical. To enter standby mode, OEn must be pulled high.

7.3.2 Data Line Biasing

The TMUXHS221LV does not contain any internal biasing. All channels of the device must be externally biased from either of the two sides to avoid floating channels.

7.4 Device Functional Modes

表 7-1. Mux Configuration Control Logic for TMUXHS221LV⁽¹⁾

SEL	OEn	Mux Configuration
L	L	D to DA
H	L	D to DB
X	H	All channels are disabled and Hi-Z

- (1) The TMUXHS221LV can tolerate polarity inversions. Ensure that the polarity consistency is maintained for all signals. However the device cannot change polarity from input to output.

8 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

8.1 Application Information

The TMUXHS221LV is an analog high-speed mux/demux that can be used for routing differential as well as single ended CMOS signals through it. The device can be used for many high speed and low speed interfaces up to 3Gbps including the following:

- Universal Serial Bus (USB) 2.0 HS, FS, and LS
- Embedded Universal Serial Bus (eUSB) 2.0 HS, FS, and LS
- Inter-Integrated Circuit (I²C) Bus
- System Management Bus (SMBus™)
- Universal Asynchronous Receiver-Transmitter (UART™)
- Debug interface signals
- Mipi® Camera Serial Interface (CSI-2), Display Serial Interface (DSI)
- PCIe® clock
- DisplayPort™ Auxiliary and Hot Plug Detect Signals
- Universal Serial Bus Type C Sideband Use (USB-C™ SBU) signals
- Low Voltage Differential Signaling (LVDS)

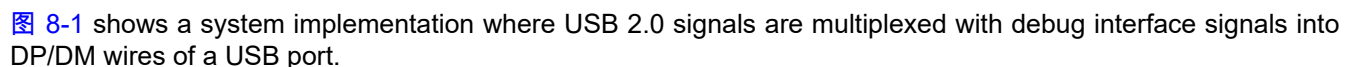
An available GPIO pin of a controller or hard tie to voltage level H or L can easily control the mux or demux selection pin (SEL) of the device as an application requires.

Many interfaces require AC coupling the capacitors between the transmitter and receiver. The 0201 or 0402 capacitors are the preferred option, but other capacitors may be used depending on interface speed and signal integrity needs. If AC coupling capacitors are used on both sides of the TMUXHS221LV, then ensure the device is biased from either side, as there is no internal biasing to the device.

8.2 Typical Applications

8.2.1 Routing Debug Signals to USB Port

Many electronic end-equipment such as PCs, media players, point of sales registers, printers, cameras, headphones, smartphones, tablets, and so forth use USB ports (such as USB Type-A, USB Type-B, or USB Type-C™) for in-field or factory debug interface. In such use cases debug signals are routed to USB 2.0 pins of a USB port through a mux or demux device. TMUXHS221LV is a good fit for such use cases with its flexible data handling capability. TMUXHS221LV can handle virtually any debug interface signals as long as they are limited to -0.3 V (minimum) to 3.6 V (maximum). The device also provides very low attenuation to both USB 2.0 and debug signals with its very low channel ON resistance, high bandwidth, and low reflection.

 8-1 shows a system implementation where USB 2.0 signals are multiplexed with debug interface signals into DP/DM wires of a USB port.

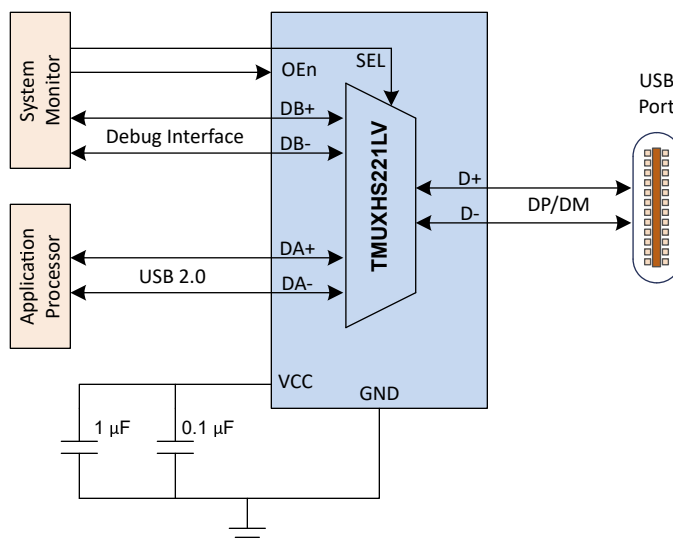


图 8-1. Routing Debug Signals to USB Port

8.2.1.1 Design Requirements

表 8-1 provides various parameters and their expected values to implement the routing debug signals into the USB port. Note that the recommendation is for illustration purpose only.

表 8-1. Design Parameters

DESIGN PARAMETER	VALUE
DA+, DA-, DB+, and DB-	Direct connect to processors, -0.3 – 3.6 V
SEL/OEn pin maximum voltage for low	0.4 V
SEL/OEn pin minimum voltage for high	1.4 V
Decoupling capacitor for VCC	0.1 µF and 1 µF

8.2.1.2 Detailed Design Procedure

Signal integrity is important because as a passive switch, the device provides no signal conditioning capability.

- Determine the loss profile between circuits that are to be muxed or demuxed.
- Provide clean impedance and electrical length matched board traces.
- Provide a control signal for the SEL and OEn pins.
- Provide good ground connection to the board ground plane.
- See the application schematics for the recommended decoupling capacitors from VCC pins to ground.

8.2.1.3 Application Curves

图 8-2 和 图 8-3 显示 USB 2.0 信号通过校准迹线（无设备）和 TMUXHS221LV 通道。A 组合 of very low channel ON resistance, high bandwidth, very low reflection (return loss), and low added jitter from the device allows 480Mbps USB 2.0 HS signals to remain unattenuated. Many system platforms struggle to pass USB 2.0 compliance due to high loss. TMUXHS221LV allows insertion of an analog mux device in the signal path without creating any additional signal integrity issues.

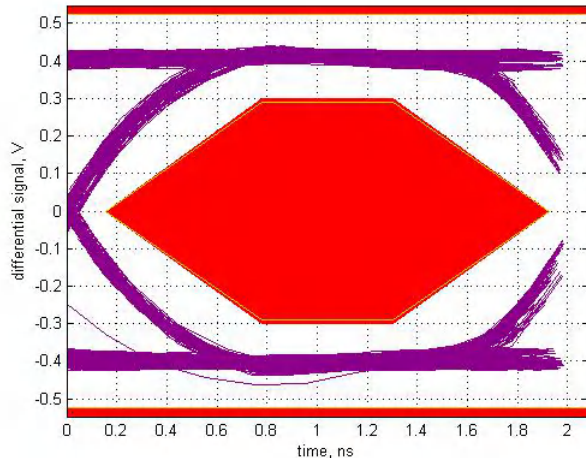


图 8-2. USB 2.0 HS Compliance Eye in TI Evaluation Board – Through Calibration Traces

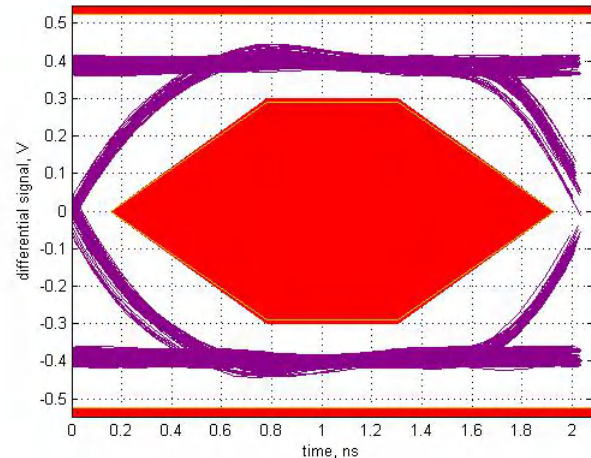


图 8-3. USB 2.0 HS Compliance Eye in TI Evaluation Board – Through TMUXHS221LV Channel

8.2.2 Systems Examples

8.2.2.1 PCIe Clock Muxing

图 8-4 显示一个应用，其中 TMUXHS221LV 用于切换 PCIe 时钟。The device is measured in a TI evaluation board with an available clock source to show an added jitter less than 10 fs for all NOISE_FOLD and PCIe 5.0 CK filter versions, which is well below PCIe 5.0 clock specifications.

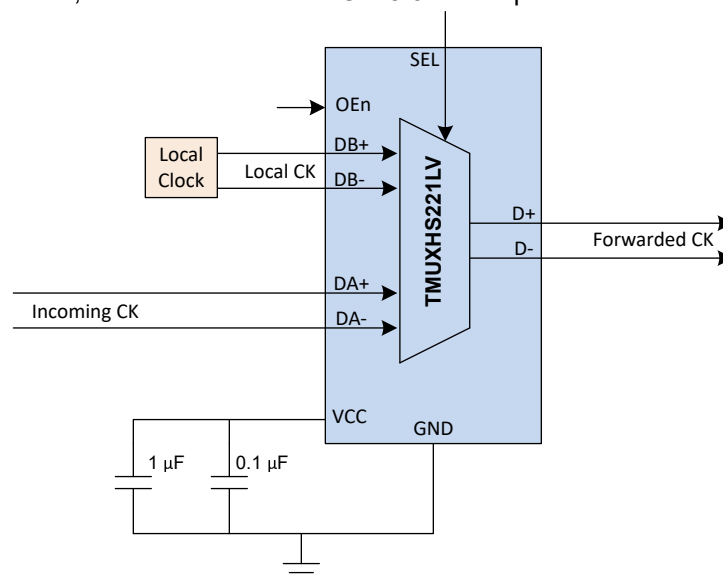


图 8-4. PCIe Clock Muxing

8.2.2.2 USB-C SBU Muxing

图 8-5 shows an application block diagram that implements SBU cross-muxing in a USB Type-C interface for implementing DisplayPort (DP) Alternate mode using the TMUXHS221LV. Note that the device has adequate bandwidth to support fast Auxiliary (AUX) signals. It is also capable of handling asymmetric biasing for DP AUX signals.

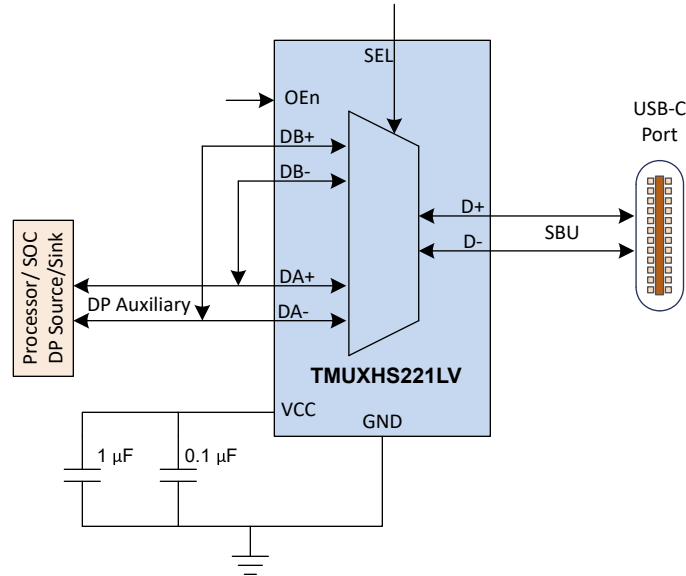


图 8-5. USB Type-C SBU Signals Muxing

8.2.2.3 Switching USB Port

图 8-6 shows an application block diagram where TMUXHS221LV is used to switch the USB port in between a hand-held portable device and its connected dock.

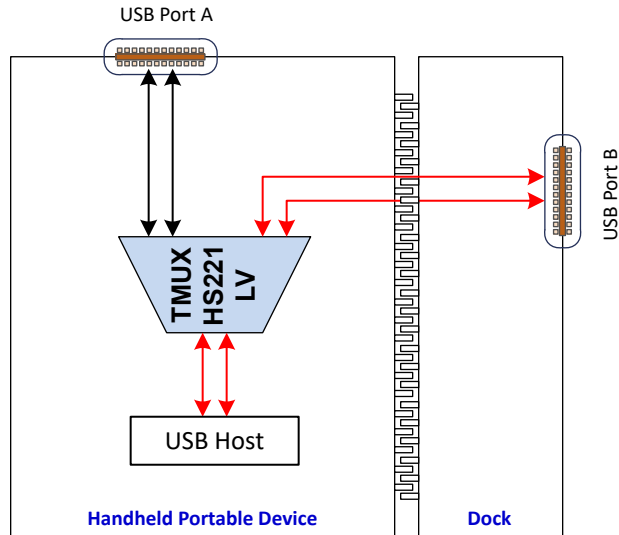


图 8-6. Switching USB Port

8.3 Power Supply Recommendations

The TMUXHS221LV does not require a power supply sequence. However, TI recommends to enable the device after VCC is stable and within specification. TI also recommends to place ample decoupling capacitors at the device VCC near the pin.

8.4 Layout

8.4.1 Layout Guidelines

A high-speed USB connection is made through a shielded, twisted pair cable with a differential characteristic impedance. In the layout, the impedance of D+ and D– traces should match the cable characteristic differential impedance for optimal performance. The high-speed D+/D– traces should always be matched and must be no more than 4 inches, otherwise the eye diagram performance may be degraded.

- Place supply bypass capacitors as close to the VCC pin as possible.
- Avoid placing the bypass capacitors near the D+/D–traces.
- Route the high-speed USB signals using a minimum of vias and corners which will reduce signal reflections and impedance changes. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. When a via must be used, increase the clearance size around it to minimize its capacitance.
- Be careful when designing test points on twisted pair lines; through-hole pins are not recommended.
- When it becomes necessary to turn 90°, use two 45° turns or an arc instead of making a single 90° turn. This reduces reflections on the signal traces by minimizing impedance discontinuities.
- Do not route USB traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices, or ICs that use or duplicate clock signals.
- Avoid stubs on the high-speed USB signals because they cause signal reflections. If a stub is unavoidable, then the stub should be less than 200 mm.
- Route all high-speed USB signal traces over continuous planes (VCC or GND) with no interruptions.
- Avoid crossing over anti-etch, commonly found with plane split.

For high speed layout guidelines, refer to [High-Speed Layout Guidelines for Signal Conditioners and USB Hubs application note](#).

8.4.2 Layout Example

图 8-7 shows a TMUXHS221LV layout example.

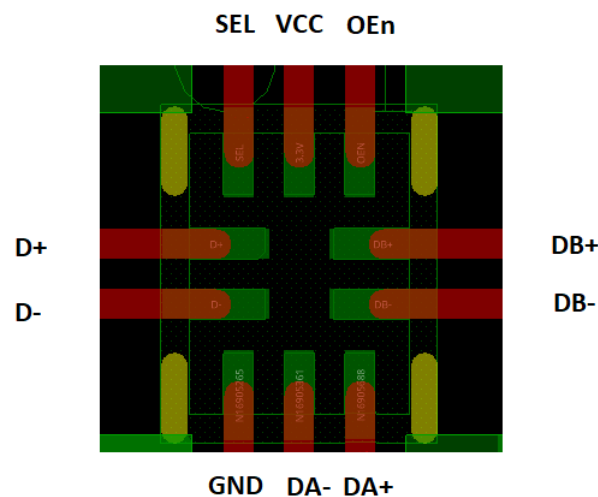


图 8-7. TMUXHS221LV Layout Example

9 Device and Documentation Support

9.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [High-Speed Layout Guidelines for Signal Conditioners and USB Hubs application note](#)

9.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](#) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

9.3 支持资源

[TI E2E™ 支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

9.6 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TMUXHS221LVNKGR	Active	Production	UQFN (NKG) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	21L
TMUXHS221LVNKGR.A	Active	Production	UQFN (NKG) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	21L
TMUXHS221LVNKG	Active	Production	UQFN (NKG) 10	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	21L
TMUXHS221LVNKG.T.A	Active	Production	UQFN (NKG) 10	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	21L

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUXHS221LVNKGR	UQFN	NKG	10	3000	180.0	8.4	1.6	2.0	0.7	4.0	8.0	Q1
TMUXHS221LVNKGT	UQFN	NKG	10	250	180.0	8.4	1.6	2.0	0.7	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

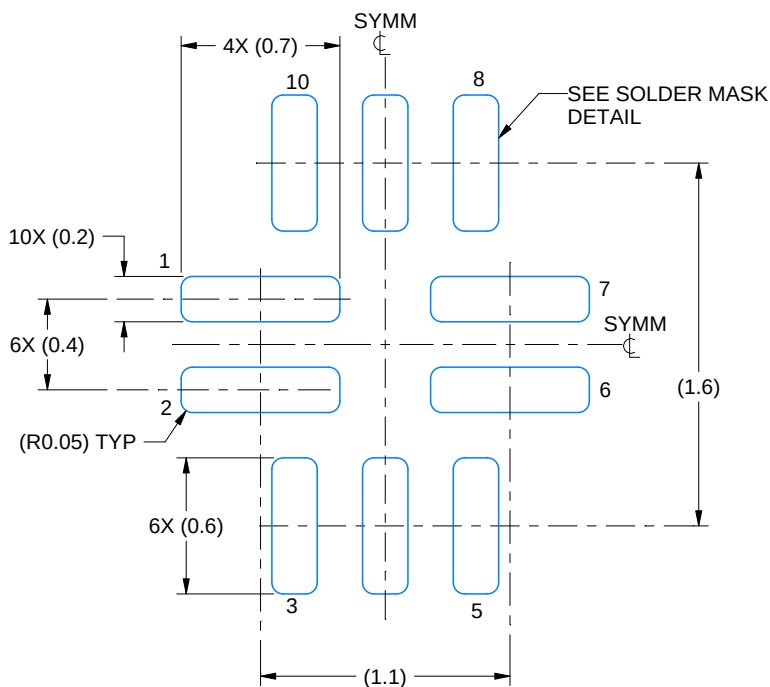
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUXHS221LVNKGR	UQFN	NKG	10	3000	210.0	185.0	35.0
TMUXHS221LVNKGT	UQFN	NKG	10	250	210.0	185.0	35.0

EXAMPLE BOARD LAYOUT

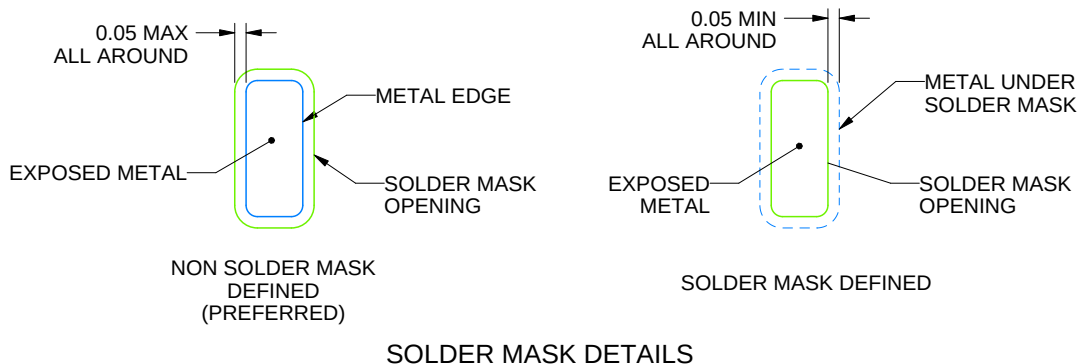
NKG0010A

UQFN - 0.55 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 30X



SOLDER MASK DETAILS

4228479/A 02/2022

NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slue271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

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